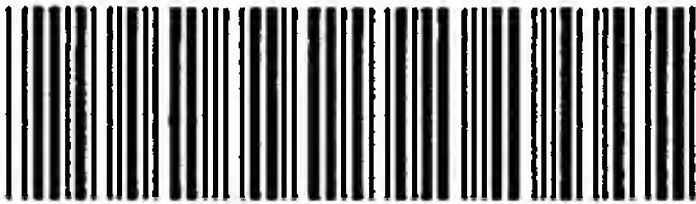


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/708,331	HSIEH ET AL.	
	Examiner	Art Unit	
	James W. Cranson	2875	

SEARCHED			
Class	Subclass	Date	Examiner
362	29	9/7/2005	JWC
362	613	9/7/2005	JWC
362	632-634	9/7/2005	JWC
349	58,65	9/7/2005	JWC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
text362/\$.CCLS.	9/6/2005	JWC
text 349/\$.ccls.	9/6/2005	JWC
EAST (ALL SEVEN DATA BASES)	9/6/2005	JWC